

Engineering Physics (2025)  
Course code 25PY101  
Module 2 Unit 2: Optoelectronics

Course Instructor:  
**Dr. Sreekar Guddeti**  
Assistant Professor in Physics  
Department of Science and Humanities  
Vignan's Foundation for Science, Technology and Research

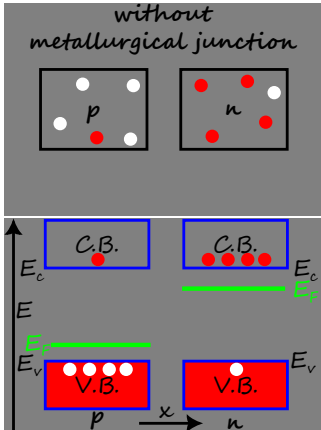
December 8, 2025

- 1 p-n junction diode – forward and reverse conditions

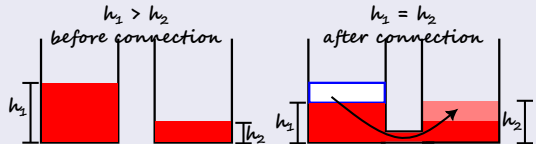
- 1 p-n junction diode – forward and reverse conditions

# Isolated p-type and n-type semiconductors

- The Fermi level of p-type semiconductor is closer to the valence band edge  $E_v$ .
- The Fermi level of n-type semiconductor is closer to the conduction band edge  $E_c$ .



## Analogy of gravitational force

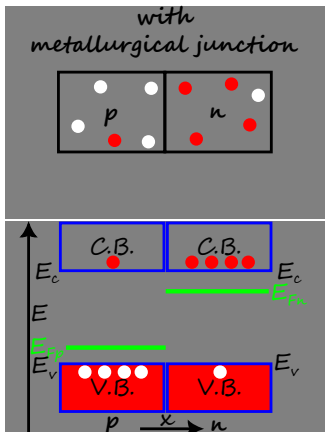


- When the glasses are connected, the gravitational force acts as driving force to reach equilibrium.
- In the case of semiconductors, the driving force to reach equilibrium is  $E_F$ .

# pn junction – Metallurgical junction

## Definition

Metallurgical junction is defined as the interface between the p-type and n-type semiconductors.



- Upon the formation of metallurgical junction, there is a difference in the Fermi level in both the regions.
- The n region has higher Fermi level  $E_{Fn}$  than p region  $E_{Fp}$ , because there are more electrons in the n-region.

\*pn junction at zero bias\*

# pn junction – at zero bias

## Definition

**Zero bias** condition is considered when external battery is not connected across p-region and n-region.

- The word voltage bias is used in the context of electricity to refer to external force.
- At zero voltage bias, there is **no application of external force** on the charge carriers.
- However, there are two internal forces at play –
  - ① Diffusion forces due to gradients in concentration of charge carriers.
  - ② Drift forces due to internal electric fields.
- The interplay of these internal forces leads to net zero force on charge carriers at thermal equilibrium.

## Key Insight

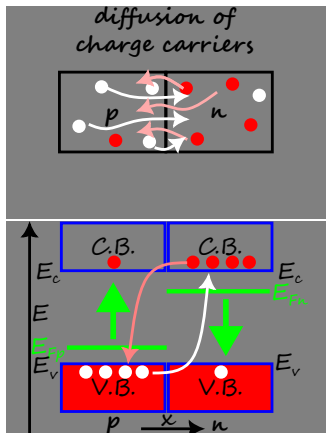


At zero bias, there is interplay of internal drift and diffusion forces.

# pn junction – Diffusion

## Definition

Diffusion is the net movement of particles from a region of higher concentration to a region of lower concentration.



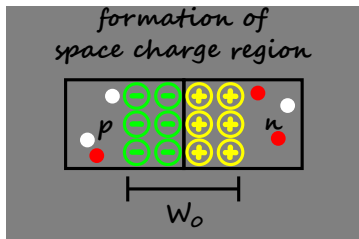
- The difference in Fermi level acts as a “driving force” so that electrons from n-region **diffuse** into the p-region.
- By similar analysis, holes from p-region diffuse into the n-region.
- Diffusion of electrons from n-region lowers its Fermi level  $E_{Fn}$ .
- Diffusion of holes from p-region raises its Fermi level  $E_{Fp}$ .



# pn junction at zero bias – Space-charge region

## Definition

- **Space charge region**, also called the **depletion region**, is the region created as a result of diffusion of free charge carriers across the metallurgical junction.
- The width of the depletion region is called depletion region width  $W_0$ .



- Due to the diffusion of mobile charge carriers, their **ionic counterparts** are left without partners.
- Space charge region is also called the **depletion region** since the region is depleted <sup>a</sup> of the free charge carriers.

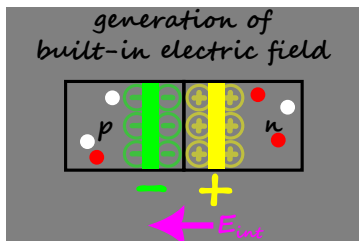
<sup>a</sup>deplete means decrease or remove.

- The depletion region consists of positively charged donor ions on the n-side of the junction and negatively charged acceptor ions on the p-side of the junction.

# pn junction at zero bias – Built-in electric field

## Definition

**Built-in electrical field**, also called internal electric field  $E_{\text{int}}$  is the electric field generated due to the oppositely charged regions on either side of the metallurgical junction.

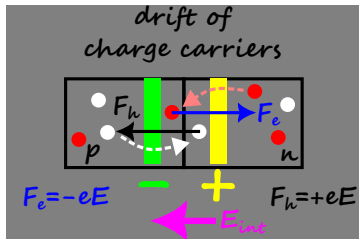


- Within the depletion region, the oppositely charged ions on either side of junction can be considered as plates of a capacitor.
  - Since the plates are charged, a **built-in electric field** is generated.
  - The built-in electric field is directed from **n-region to p-region**.
- $E_{\text{int}}$  prevents further build up of space charge due to diffusion as it opposes the diffusion of electrons from n-region into p-region and vice versa.

# pn junction at zero bias – Drift

## Definition

Drift is the net movement of charged particles due to the application of electric field.

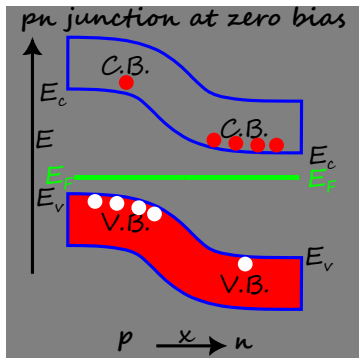


- Consider a diffused electron that is present in the p side of the depletion region.
- Since the built-in electric field is directed from **n-region to p-region**, the electric force is directed from **p-region to n-region**.
- Electron drift backs to the n-region.
- The diffusion force is counterbalanced by the drift force.
- Similar analysis applies to the diffused hole.

## Problem

*Prove the counterbalancing effect of drift and diffusion for holes.*

# pn junction at zero bias – Thermal equilibrium



## Definition

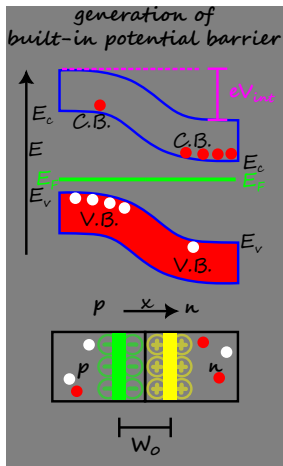
Thermal equilibrium occurs when the net force on the system is zero.

- Since the difference in Fermi level is a “driving” force, when the system reaches thermal equilibrium, the net force is zero.
- This implies the Fermi level is a constant throughout the system at thermal equilibrium.
- Since the external force is zero at zero bias, the pn junction is at thermal equilibrium.

## Key Insight

At thermal equilibrium,  $E_F$  is a constant.

# pn junction at zero bias – Built-in potential barrier



## Definition

**Built-in potential barrier**  $V_{int}$  is the potential difference generated across the oppositely charged halves of the depletion region.

- If we model the depletion region as a capacitor with electric field  $E_{int}$  between the plates and the separation between the plates is  $W$ , then the potential difference across the plates is given by

$$E_{int} = \frac{V_{int}}{W_0} \Rightarrow V_{int} = E_{int} W_0$$

## Key Insight

Potential barrier is proportional to the built-in electric field.

\*pn junction at non-zero bias\*

## pn junction – at non-zero bias

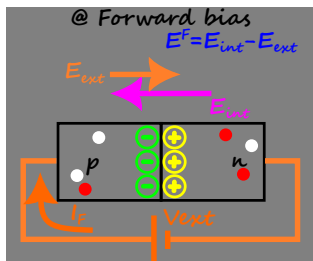
- At non-zero voltage bias, there is **an application of external force** on the charge carriers. As a result, the pn junction cannot attain thermal equilibrium.
- Since there is no thermal equilibrium, the Fermi energy is not a constant across the pn junction.
- Since the direction of built-in electric field is from n-region to p-region, the behaviour of p-n junction is different when the external field  $E_{\text{ext}}$  is parallel or anti-parallel to the built-in electric field  $E_{\text{int}}$ .
  - 1  $E_{\text{ext}} \uparrow \downarrow E_{\text{int}}$  corresponds to forward biasing.
  - 2  $E_{\text{ext}} \uparrow \uparrow E_{\text{int}}$  corresponds to reverse biasing.

### Key Insight



At non zero bias, the Fermi energy is not a constant across the pn junction.

# pn junction – at forward bias



## Definition

**Forward bias** condition is considered when the positive electrode of battery with potential  $V_F$  is connected to p-region and negative electrode is connected to n-region.

- The external bias  $V_{\text{ext}} = V_F$  is from p-region to n-region.
- The external field  $E_{\text{ext}}$  is from p-region to n-region. The internal field  $E_{\text{int}}$  is **anti-parallel** to  $E_{\text{ext}}$ . The net electric field  $E^F$  is lower than the case of zero bias.
- So less space charge is created in depletion region. So we have smaller space charge width  $W_F$ .

### Forward

$$V_F > 0$$

$$E^F < E_{\text{int}}$$

$$W_F < W_0$$

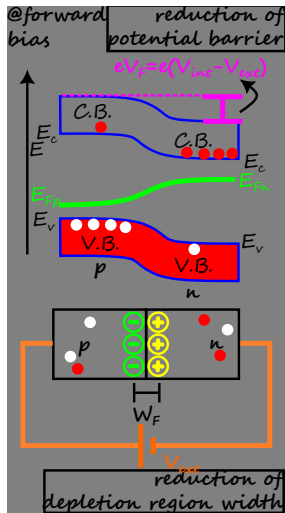
$$V_F < V_{\text{int}}$$

$$E_{F_n} - E_{F_p} > 0$$

$$I_F > 0$$

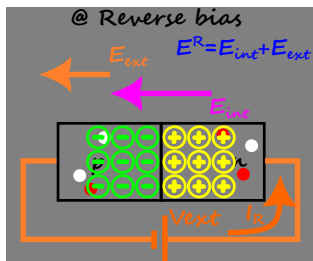


# pn junction – at forward bias



- Since potential is proportional to electric field, potential barrier  $V_F$  is lowered.
- From the band diagram, Fermi energy of n-region  $E_{Fn}$  is higher than Fermi energy of p-region  $E_{Fp}$ .
- So electrons will move from n region to p-region. This leads to current from p-region to n-region. This is called forward bias current  $I_F$ .
- Since electrons are present in n-region this leads to **good conduction** of pn-junction.

# pn junction – at reverse bias



## Definition

**Reverse bias** condition is considered when the positive electrode of battery is connected to n-region and negative electrode is connected to p-region.

- The external bias  $V_{\text{ext}} = V_R$  is from n-region to p-region.
- The external field is from n-region to p-region. Under reverse bias condition, the internal field is **parallel** to the external field. The net electric field  $E^R$  is higher than the case of zero bias.
- So more space charge is created in depletion region. So we have larger space charge width  $W_R$ .

---

Reverse

---

$$V_R < 0$$

$$E^R > E_{\text{int}}$$

$$V_R > V_{\text{int}}$$

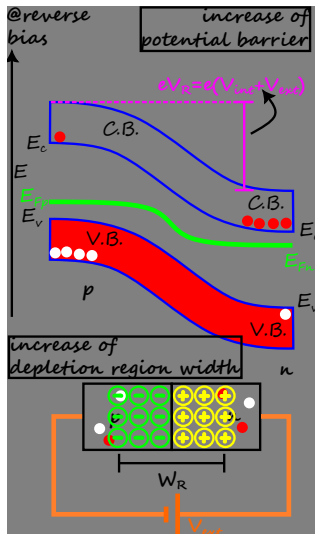
$$E_{F_n} - E_{F_p} < 0$$

$$W_R > W_0$$

$$I_R < 0$$

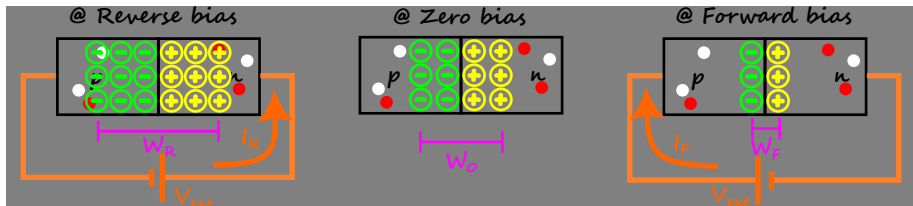
---

# pn junction – at reverse bias



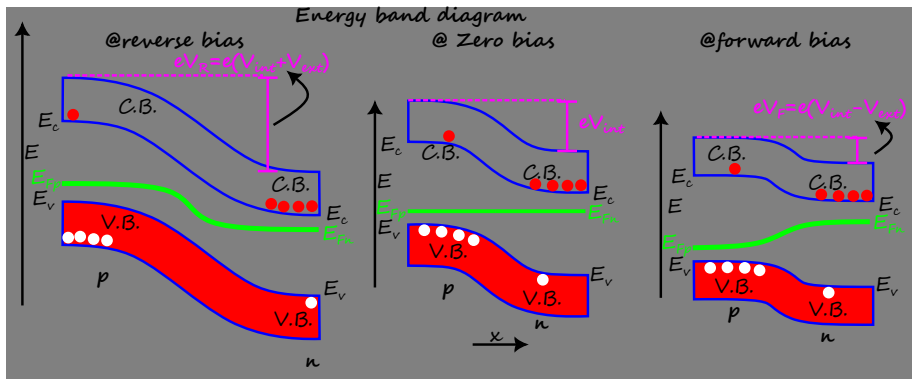
- Since potential is proportional to electric field, potential barrier  $V_R$  is raised.
- From the band diagram, Fermi energy of n-region  $E_{Fn}$  is lower than Fermi energy of p-region  $E_{Fp}$ .
- So electrons want to move from p region to n-region. But only minority carriers are there in p region.
- Since very few electrons are present in n-region this leads to **poor conduction** of pn-junction and the current is called reverse bias current  $I_R$ .

# Comparison of depletion region widths at different biases



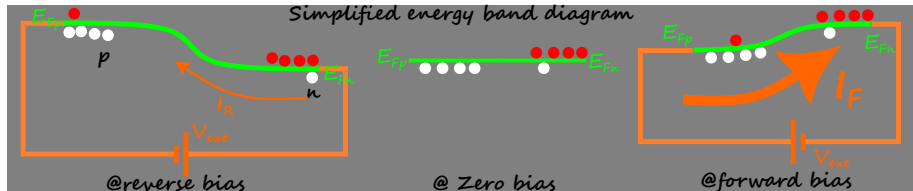
$$W_R > W_0 > W_F$$

# Comparison of potential barrier at different biases



$$V_R > V_{int} > V_F$$

# Concept of simplified energy band diagram



- Energy band diagram has many features. It is sometimes useful to represent the most essential things of the energy band diagram.
- We have used the potential energy barrier to understand motion of charge carriers. However, Fermi level can also be used for the analysis.
- The band diagram that contains only the variation of Fermi level along with charge carriers is called simplified band diagram.
- The electrons can be imagined to occupy the Fermi level on the top side and holes can be imagined to occupy the Fermi level on the bottom side.
- The **electrons want to reach lower levels** of Fermi energy whereas holes **want to reach higher levels** of Fermi energy.

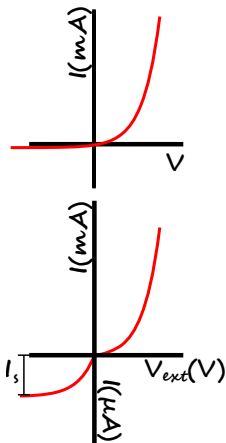
# Large forward current vs tiny reverse current

- Under biasing conditions, the electrodes of the battery change the Fermi levels of the p and n regions.
- Since the negative electrode supplies electrons, it raises the Fermi level of the connected region. Similarly, positive electrode lowers the Fermi level.
- Under forward biasing, the energy of electrons at n-region is raised. The flow of electrons to lower energy p-region is possible. Similarly, the energy of holes at p-region is lowered. The flow of holes to higher energy n-region is possible. This leads to **large forward current**.
- Under reverse biasing, the energy of electrons at n-region is lowered. The flow of electrons to higher energy p-region is difficult. Similarly, the energy of holes at p-region is raised. The flow of holes to lower energy p-region is difficult.
- However, the reverse bias is favourable for minority electrons in p region and minority holes in n-region. Since the number of these carriers is very few, we see a **tiny reverse current**.

# pn junction – $I - V$ characteristics

## Definition

**Rectifying action** of pn junction is its property to allow **uni-directional** conduction.



- The diode equation can be shown to be

$$I = I_s \left[ \exp \left( \frac{eV}{k_B T} \right) - 1 \right]$$

where  $I_s$  is the reverse saturation current.

- The equation and the  $I - V$  capture the non-linear nature of p-n junction.
- In the forward bias condition, it acts as a “closed switch” allowing large current to flow through it.
- In the reverse bias condition, it acts as an “open switch” allowing insignificantly low current to flow through it.
- This unidirectional conduction is called rectifying action.



# pn junction – Reverse Saturation Current

## Definition

The drift current due to minority carriers is known as **reverse saturation current**.

- As the reverse bias increases in magnitude, the reverse bias current saturates to a constant and is given by

$$\begin{aligned} & \lim_{V \rightarrow -\infty} I_s \left[ \exp \left( \frac{eV}{k_B T} \right) - 1 \right] \\ &= I_s [\exp(-\infty) - 1] \\ &= I_s(0 - 1) \\ &= -I_s \end{aligned}$$

- This saturation current in the reverse bias direction is called reverse saturation current.
- Since the minority carrier concentration does not depend on the bias and only depends on the temperature, it is a constant at a given temperature.

# Electrical power

## Definition

Power is defined as the rate change of work done per unit time.

- The mechanical power  $P_{\text{mech}}$  is given by

$$P_{\text{mech}} = \frac{dW}{dt} = \frac{dFs}{dt},$$
$$= F \frac{ds}{dt} = Fv.$$

Here  $F$  is the force applied along displacement  $s$  to do work  $W = Fs$  on a particle moving with velocity  $v$ .

- The electrical power consumed along a resistor  $P_{\text{elec}}$  for one electron is given by  $P_{\text{elec}} = Fv = -eEv_d$  where  $v_d$  is the drift velocity.
- The power consumed within a length  $L$  and area  $A$  of resistor with electron concentration  $n$  is  
 $P_{\text{elec}} = -nLAeEv_d = -VjA = -VI$   
where  $V = El$  is the potential drop across the resistor and  $I = jA$  is current across the resistor. Here we have used definition of current density  $j = nev_d$ .

# pn junction – Power characteristics

## Definition

The sign convention employed for power consumption is if the current direction is along the voltage drop, then power is consumed and if the current direction is opposite the voltage drop, then power is generated.

	R	B	pn
$V_F$	$> 0$	$> 0$	$> 0$
$I_F$	$> 0$	$< 0$	$\gg 0$
$P_F$	$> 0$	$< 0$	$\gg 0$
$V_R$	$< 0$	N.A.	$< 0$
$I_R$	$< 0$	N.A.	$< 0$
$P_R$	$> 0$	N.A.	$> 0$

- For the resistor, the current is always along the voltage drop, even if the voltage drop is reversed. Therefore, the power is consumed in both biases.
- For the battery, the current is opposite to the voltage drop, Therefore, power is generated in a battery.
- For the pn junction, the current is along the voltage drop in both cases. Therefore, the power is consumed in both biases. However, the magnitudes are different unlike resistor.

# Conceptual Questions

## Problem

*What causes majority carriers to flow at the moment when p-region and n-region are brought together? Why does this flow not continue until all carriers have recombined? [Hint for second part: Convince yourself that the built-in electric field opposes the diffusion “forces” for both the electrons and holes.]*

## Tough problems

## Problem

*Prove that the analysis of pn junction using potential energy barrier maps with the analysis using Fermi energy level. In other words, prove that  $E_{Fn} - E_{Fp} = eV_{\text{ext}}$ .*